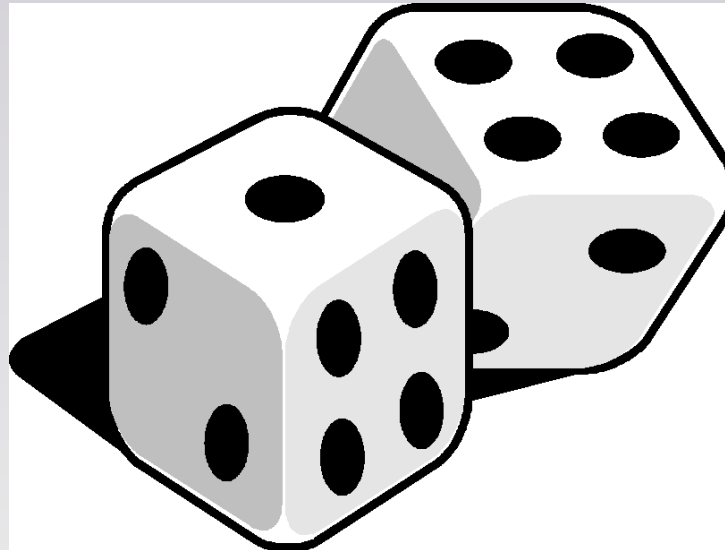


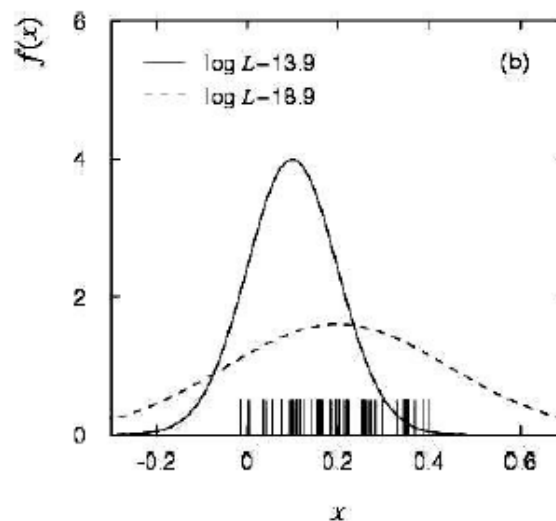
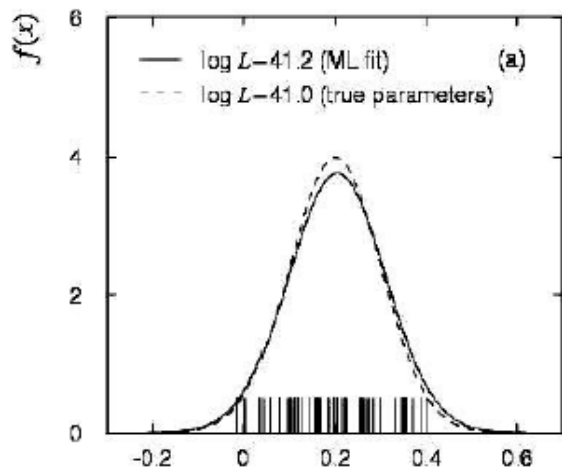
# Statistics In HEP 2

How do we understand/interpret our measurements



- **Maximum Likelihood fit**
- **strict frequentist Neyman – confidence intervals**
  - **what “bothers” people with them**
- **Feldmans/Cousins confidence belts/intervals**
- **Bayesian treatment of ‘unphysical’ results**
- **How the LEP-Higgs limit was derived**
- **what about systematic uncertainties?**
  - **Profile Likelihood**

- **want to measure/estimate some parameter  $\theta$** 
  - e.g. mass, polarisation, etc..
- **observe:  $\vec{x}^i = (x_1, \dots, x_n)_i \quad i = 1, K$** 
  - e.g.  $n$  observables for  $K$  events
- **“hypothesis” i.e. PDF  $P(\vec{x}; \theta)$  - distribution  $\vec{x}$  for given  $\theta$** 
  - e.g. diff. cross section
  - $K$  independent events:  $P(\vec{x}^1, \dots, \vec{x}^K; \theta) = \prod_i^K P(\vec{x}^i; \theta)$
- **for fixed  $\vec{x}$  regard  $P(\vec{x}; \theta)$  as function of  $\theta$  (i.e. **Likelihood!**  $L(\theta)$ )**
  - $\theta$  close to  $\theta_{true}$  → **Likelihood**  $L(\theta)$  will be large



- try to maximise  $L(\theta)$
- typically:
  - minimize -  $2\text{Log}(L(\theta)) \rightarrow \hat{\theta}$

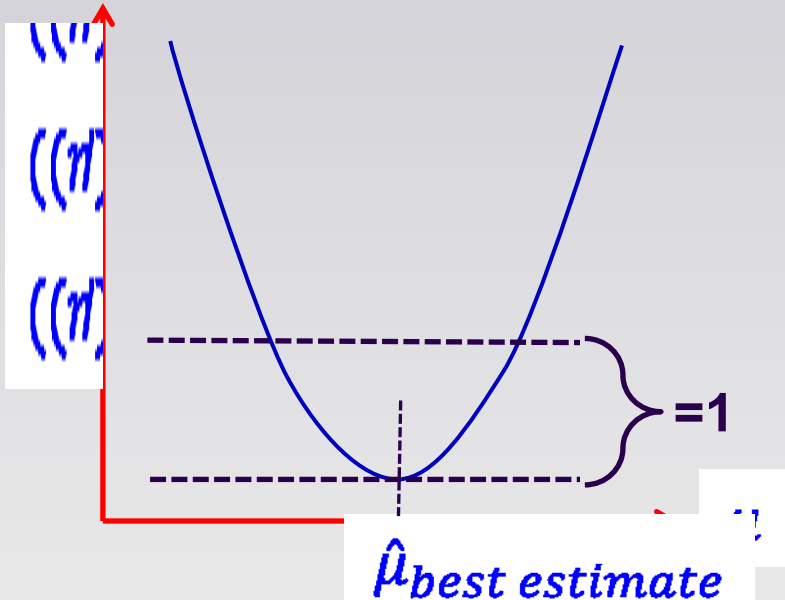
→ **Maximum Likelihood estimator**

**example:** PDF(x) = Gauss(x, μ, σ) →  $L(x|Gauss(\mu)) = \frac{1}{\sqrt{2\pi\sigma}} \exp\left(-\frac{(x-\mu)^2}{2\sigma^2}\right)$

→ estimator for  $\mu_{true}$  from the data measured in an experiment  $x_1, \dots, x_K$

→ full Likelihood  $L(x|\mu) = \prod_i^K \frac{1}{\sqrt{2\pi\sigma}} \exp\left(-\frac{(x_i-\mu)^2}{2\sigma^2}\right)$

→ typically:  $-2\ln(L(x|\mu)) = \sum_i^K \frac{1}{\sqrt{2\pi\sigma}} \left(\frac{(x_i-\mu)^2}{2\sigma^2}\right)$  **Note: It's a function of μ !**

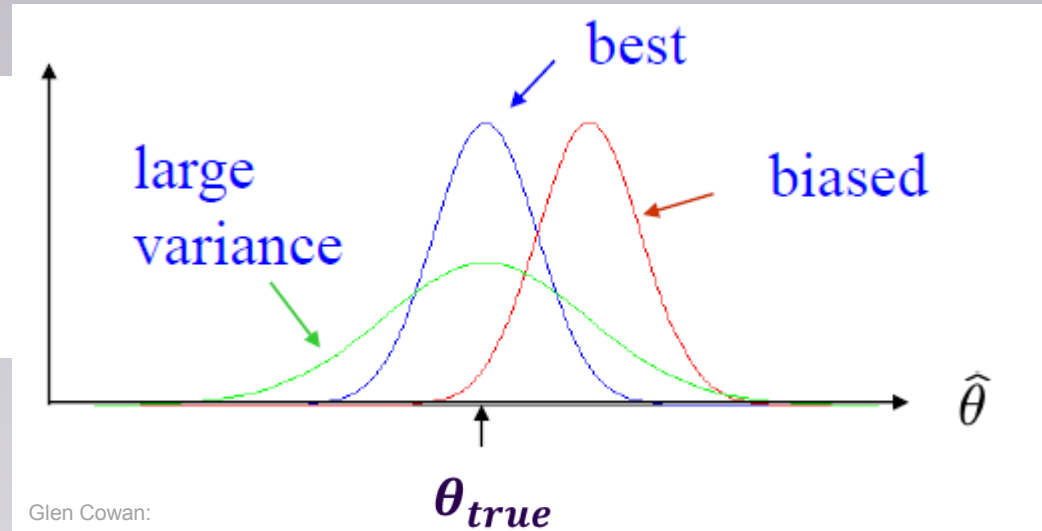


For Gaussian PDFs:  
 $-2\ln(L(\mu)) = \chi^2$

▪  $\Delta 2\ln(L) = 1$  from  $\hat{\mu} \rightarrow$  interval  $[\mu_1; \mu_2]$   
 → variance on the estimate  $\hat{\mu}$

## properties of estimators

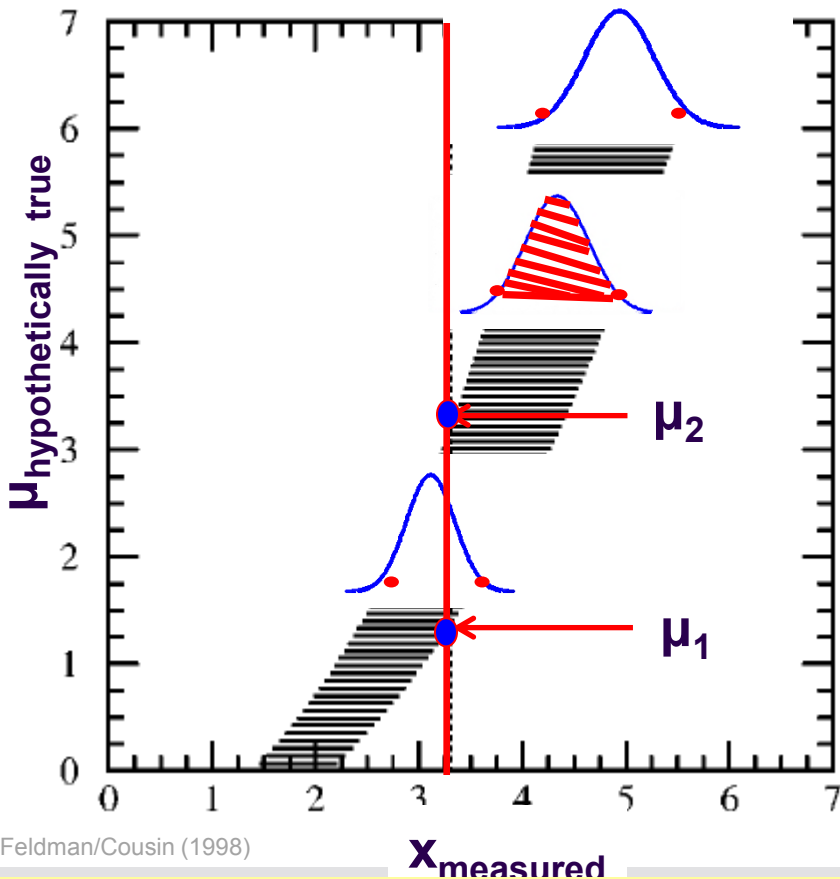
- **biased or unbiased**
- **large or small variance**
- **distribution of  $\hat{\theta}$  on many measurements ?**



- **Small bias and small variance are typically “in conflict”**
- **Maximum Likelihood is typically unbiased only in the limit  $K \rightarrow \infty$** 
  - **If Likelihood function is “Gaussian” (often the case for large  $K$  → central limit theorem)**
    - **get “error” estimate from or  $-2\Delta\log(L) = 1$**
    - **If (very) none Gaussian**
      - **revert typically to (classical) Neyman confidence intervals**

another way to look at a measurement rigorously “frequentist”

- Neymans Confidence belt for CL  $\alpha$  (e.g. 90%)

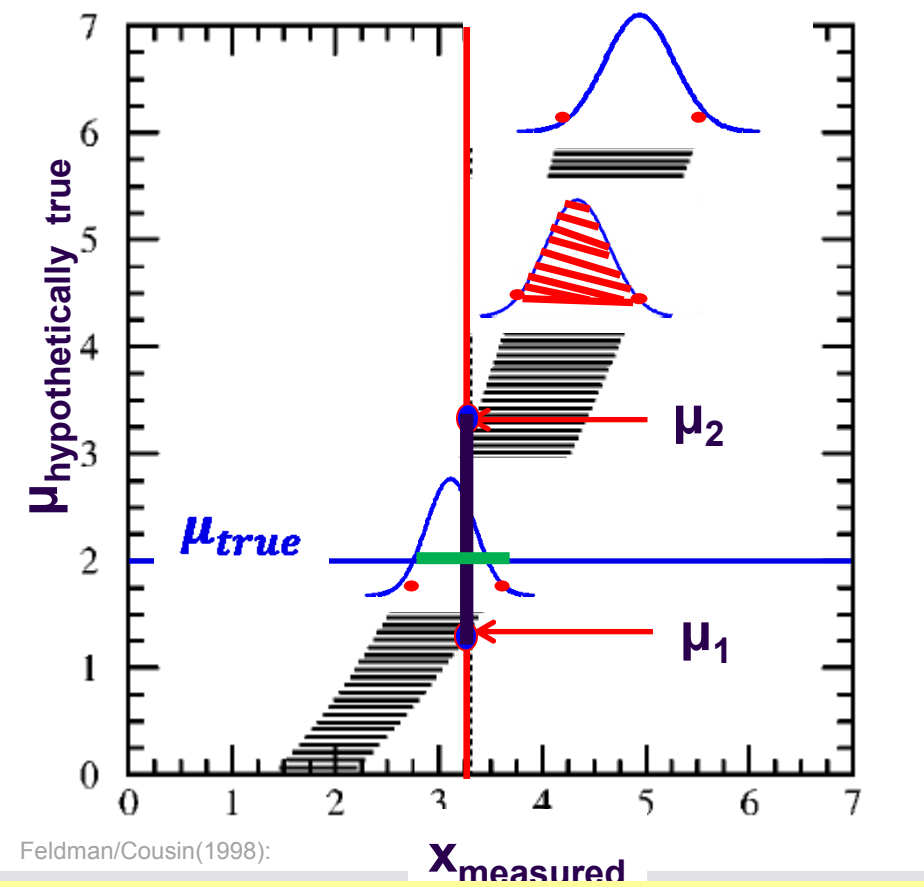


- each  $\mu_{\text{hypothetically true}}$  has a PDF of how the measured values will be distributed
- determine the (central) intervals (“acceptance region”) in these PDFs such that they contain  $\alpha$
- do this for ALL  $\mu_{\text{hyp.true}}$
- connect all the “red dots”  $\rightarrow$  confidence belt
- measure  $x_{\text{obs}}$  :  
 $\rightarrow$  conf. interval  $= [\mu_1, \mu_2]$  given by **vertical** line intersecting the belt.

▪ by construction: for each  $x_{\text{meas.}}$  (taken according PDF( $\mu_{\text{true}}$  ) the confidence interval  $[\mu_1, \mu_2]$  contains  $\mu_{\text{true}}$  in  $\alpha = 90\%$  cases

another way to look at a measurement rigorously “frequentist”

- Neymans Confidence belt for CL  $\alpha$  (e.g. 90%)



Feldman/Cousin(1998):

→ conf.interval =  $[\mu_1, \mu_2]$  given by **vertical** line intersecting the belt.

- by construction:

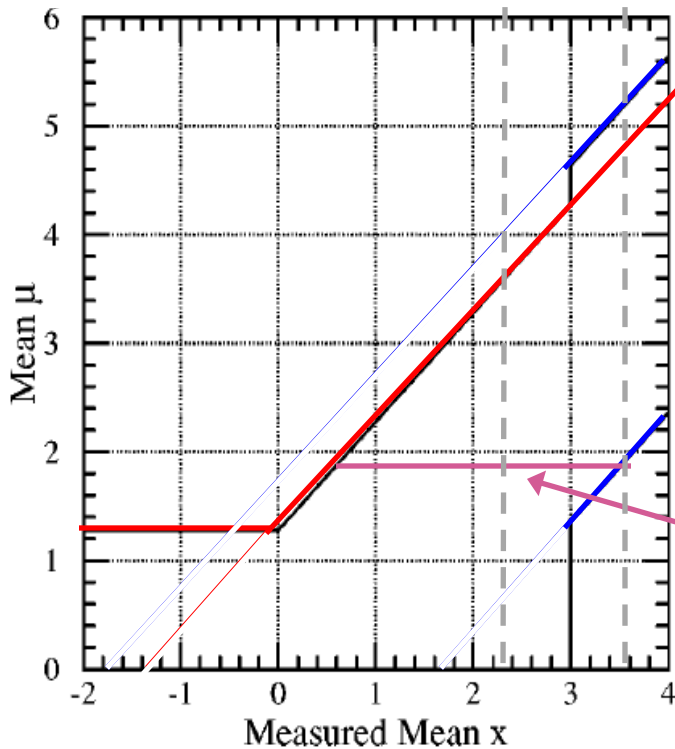
- $P(x < x_{obs}; \mu_2) = \frac{1-\alpha}{2}$
- $P(x > x_{obs}; \mu_1) = \frac{1-\alpha}{2}$

- if the true value were  $\mu_{true}$
- lies in  $[\mu_1, \mu_2]$  if it intersects
- $x_{meas}$  intersects — as in 90% (that's how it was constructed)
- only those  $x_{meas}$  give  $[\mu_1, \mu_2]$ 's that intersect with the —
- 90% of intervals cover  $\mu_{true}$

▪  $P(x; \mu)$  is Gaussian ( $\sigma = const$ ) → central 68% Neyman Conf. Intervals  
 ⇔ Max. Likelihood + its “error” estimate  $[\hat{x} - \sigma_{\hat{x}}; \hat{x} + \sigma_{\hat{x}}]$

## When to quote measurement or a limit!

- estimate Gaussian distributed quantity  $\mu$  that cannot be  $< 0$  (e.g. mass)
- same Neuman confidence belt construction as before:
  - once for measurement (two sided, each tail contains 5% )
  - once for limit (one sided tails contains 10%)



Feldman/Cousins(1998)

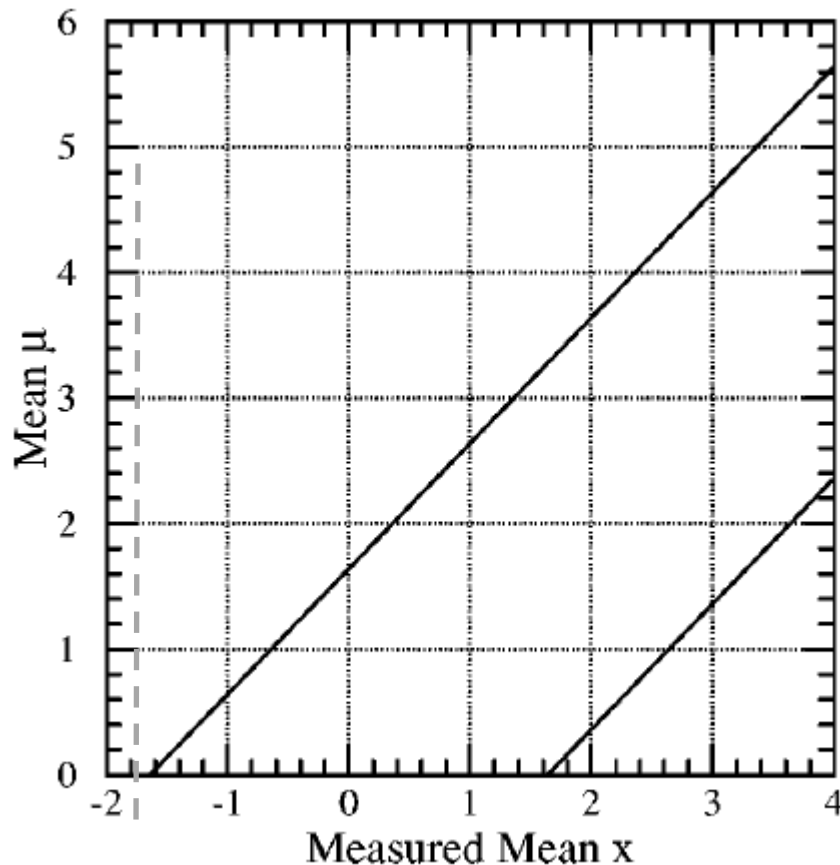
- decide: if  $x_{obs} < 0$  assume you = 0
  - conservative
- if you observe  $x_{obs} < 3$ 
  - quote upper limit only
- if you observe  $x_{obs} > 3$ 
  - quote a measurement

→ induces “undercovering” as this acceptance region contains only 85% !!



same example:

- estimate Gaussian distributed quantity  $\mu$  that cannot be  $< 0$  (e.g. mass)



Feldman/Cousins(1998).

- using proper confidence belt
- assume:  $x_{obs} = -1.8$   
→ confidence interval is EMPTY!

- Note: that's OK from the frequentist interpretation  
 $\mu_{true} \in [conf. interv.]$  in 90% of (hypothetical) measurements.

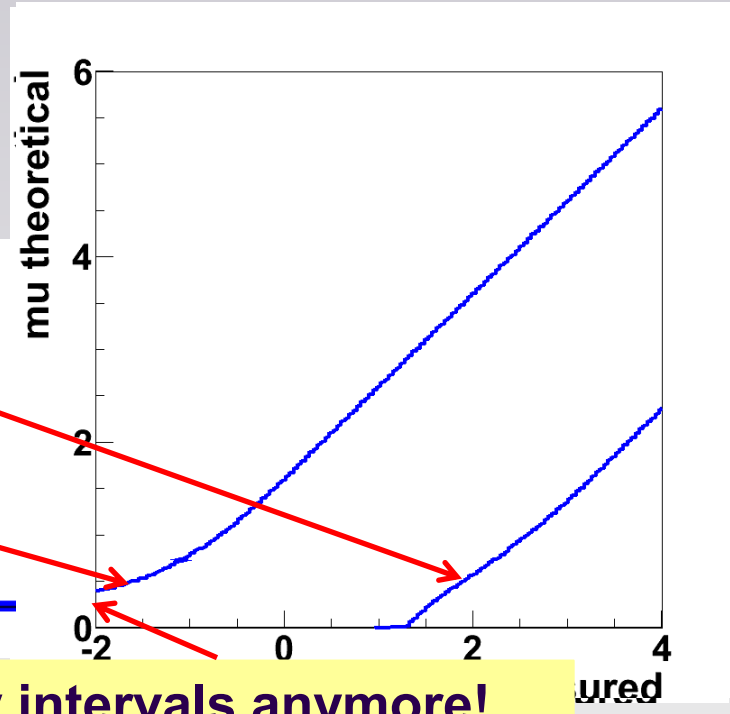
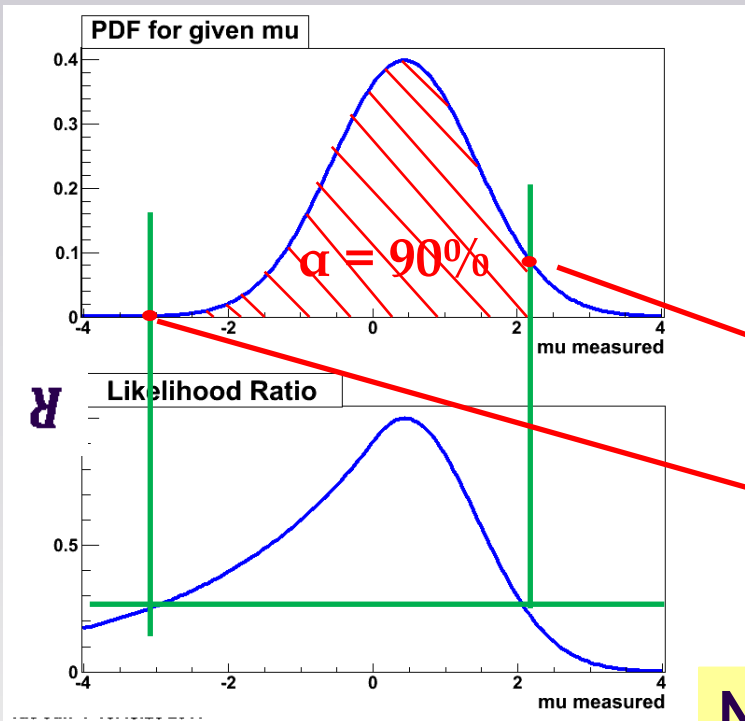
Obviously we were 'unlucky' to pick one out of the remaining 10%

- nonetheless: tempted to "flip-flop" ??? tsz .. tsz.. tsz..

- How we determine the “acceptance” region for each  $\mu_{\text{hyp.true}}$  is up to us as long as it covers the desired integral of size  $\alpha$  (e.g. 90%)
- include those “ $x_{\text{meas.}}$ ” for which the large likelihood ratio first:

$$R = \frac{L(x_{\text{meas}}|\mu_{\text{measured}})}{L(x_{\text{meas}}|\mu_{\text{best estimate}})}$$

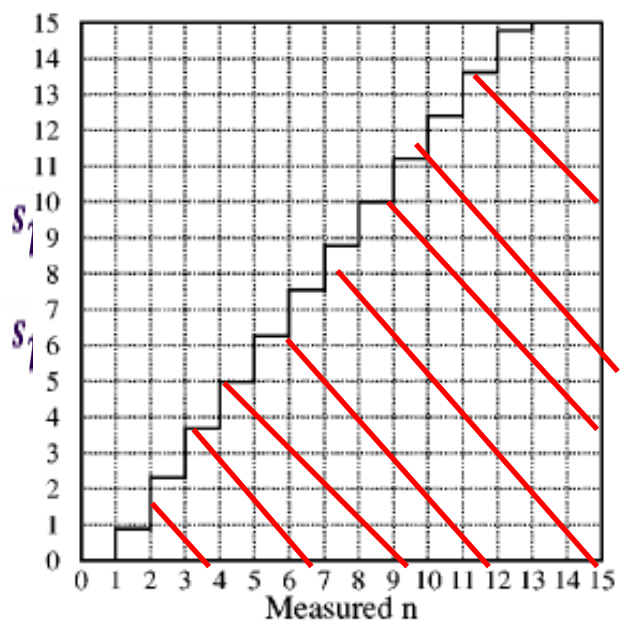
- $\mu_{\text{best estimate}}$  here: either the observation  $x_{\text{meas}}$  or the closes ALLOWED  $\mu$



No “empty intervals anymore!”

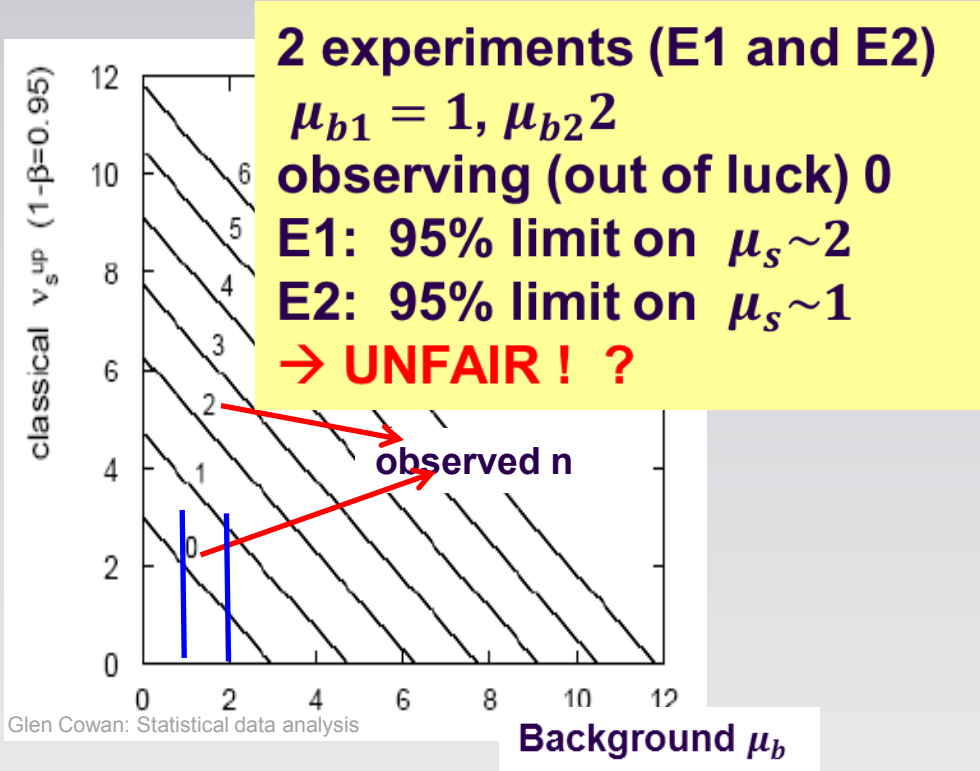
# Being Lucky...

- give upper limit on signal  $\mu_s$  on top of know (mean) background  $\mu_b$ 
  - $\rightarrow n=s+b$  from a poisson distribution
  - $P(n) = \text{Poisson}(n, \mu_s + \mu_b)$
- Neyman: draw confidence belt with
  - " $\mu_s$ " in the "y-axis" (the possible true values of  $\mu_s$ )



for fixed Background  $\mu_b$

sorry... the plots don't match: one is of 90%CL the other for 95%CL



Glen Cowan: Statistical data analysis

Background  $\mu_b$

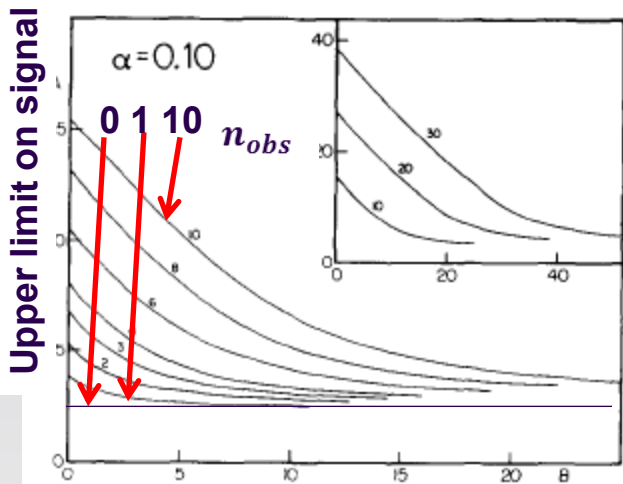
- Feldman/Cousins confidence belts
  - motivated by “popular” ‘Bayesian’ approaches to handle such problems.

## Bayesian: rather than constructing Confidence belts:

- turn Likelihood for  $\mu_s$  (on given  $n_{obs}$ ) into Posterior probability on  $\mu_s$  i.e  $Poisson(n_{obs}; \mu_s + \mu_b)$
- $p(\mu_s | n_{obs}) = L(n_{obs}; \mu_s) * \pi(\mu_s)$  add prior probability on “s”:
- $\pi(\mu_s) = \begin{cases} 0 & \mu_s < 0 \\ \text{uniform} & \mu_s > 0 \end{cases}$

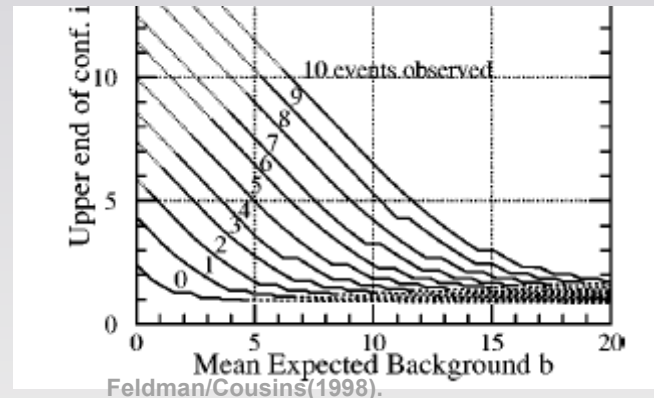
## Feldman/Cousins

- there is still SOME “unfairness”
- perfectly “fine” in frequentist interpretation:
- should quote “limit+sensitivity”



Helene(1983). s figure 1, here t

Background b



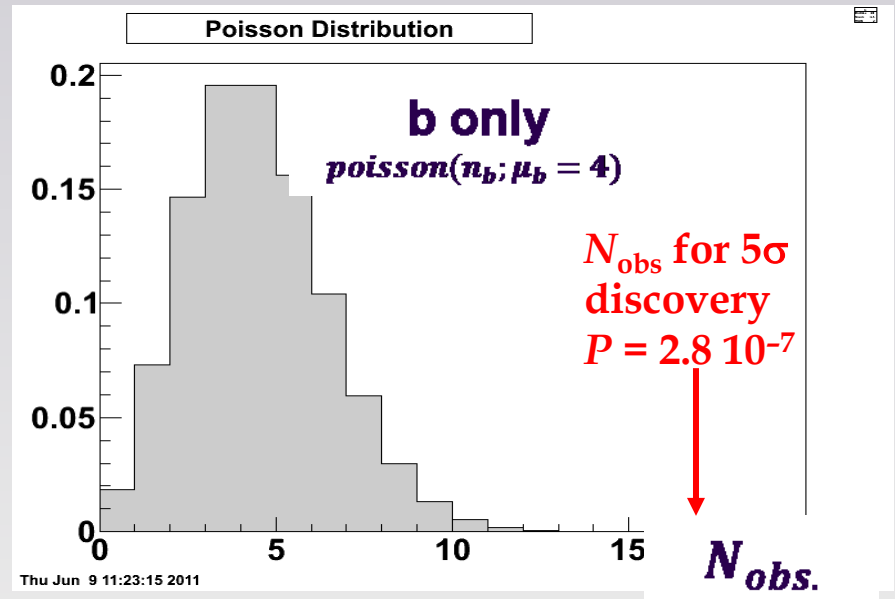
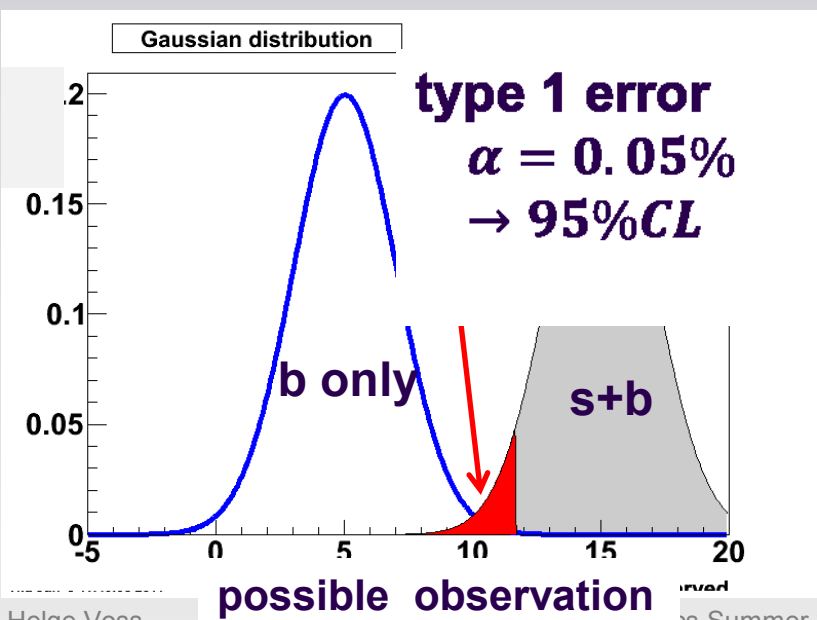
Feldman/Cousins(1998).

## exclusion limits

- **upper limit on cross section**  
( $\leftrightarrow$  lower limit on mass scale)
- ( $\sigma < \text{limit}$  as otherwise we would have seen it)
- ➔ need to estimate probability of **downward** fluctuation of **s+b**
- ➔ try to **“disprove”**  $H_0 = s+b$
- ➔ better: find **minimal s**, for which you can still exclude  $H_0 = s+b$  a pre-specified **Confidence Level**

## discoveries

- ➔ need to estimate probability of **upward** fluctuation of **b**
- ➔ try to **disprove**  $H_0 = \text{“background only”}$



## exclusion limit:

- test statistic does not necessarily have to be simply the counted number of events:

→ remember Neyman Pearson → Likelihood ratio

→  $t(n_{obs}) = \frac{Poisson(n_{obs};s,b)}{Poisson(n_{obs};b)}$

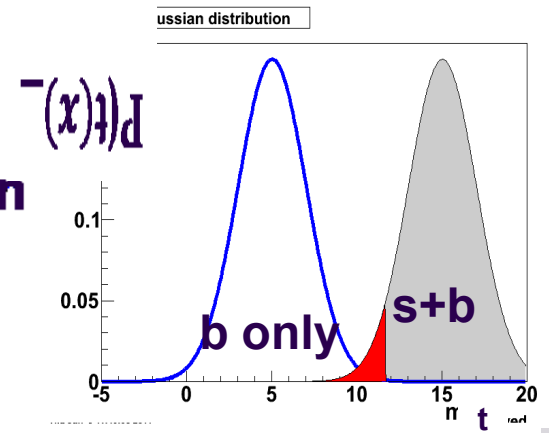
→ pre-specify  $\alpha = 0.05\%$  → 95% CL on exclusion

→ make your measurements

→ If accepted (i.e. in “critical (red) region”) where you decided to “reject”  $H_0 = s+b$

→  $CL_{s+b} = P(t < t_{obs})$

→ (i.e. what would have been the chance for THIS particular measurement to still have been “fooled” and there would have actually BEEN a signal)

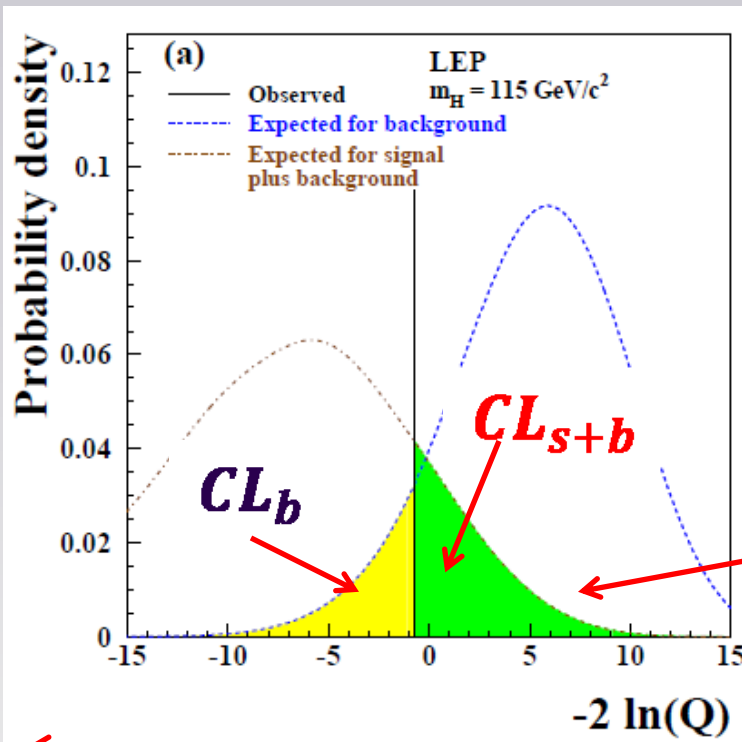


# Example : LEP-Higgs search

Remember: there were 4 experiments, many different search channels  
 → treat different experiments just like “more channels”

$$Q = \frac{L(x|H_1)}{L(x|H_0)} = \frac{\prod_i^{N_{chan}} Pois(n_i | s_i + b_i) \prod_j^{n_i} \frac{s_i f_s(x_{ij}) + b_i f_b(x_{ij})}{s_i + b_i}}{\prod_i^{N_{chan}} Pois(n_i | b_i) \prod_j^{n_i} f_b(x_{ij})}$$

$$q = \ln Q = -s_{tot} + \sum_i^{N_{chan}} \sum_j^{n_i} \ln \left( 1 + \frac{s_i f_s(x_{ij})}{b_i f_b(x_{ij})} \right)$$



- Evaluate how the  $-2\ln Q$  is distributed for
  - background only
  - signal+background
  - (note: needs to be done for all Higgs masses)

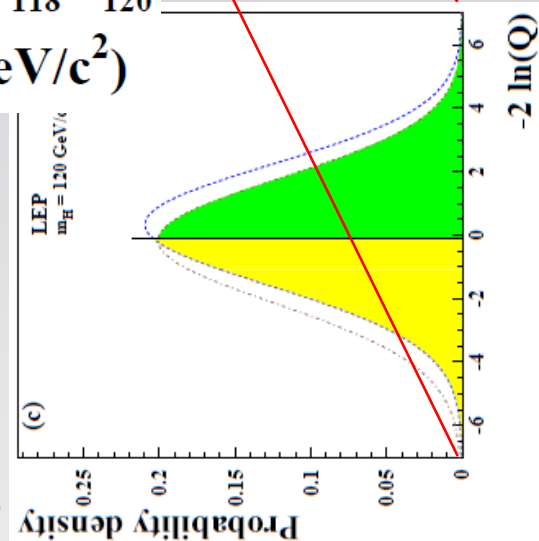
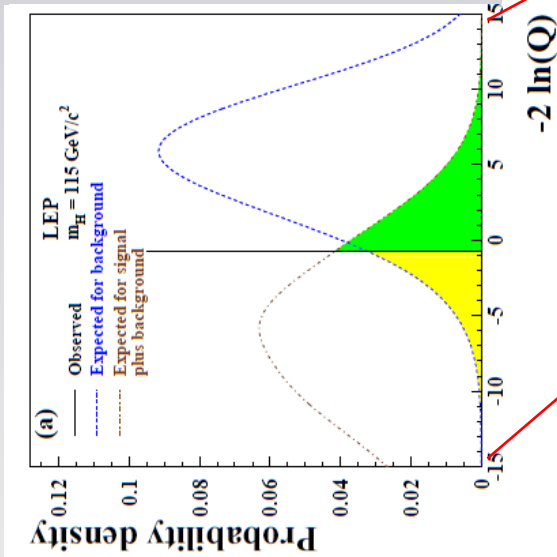
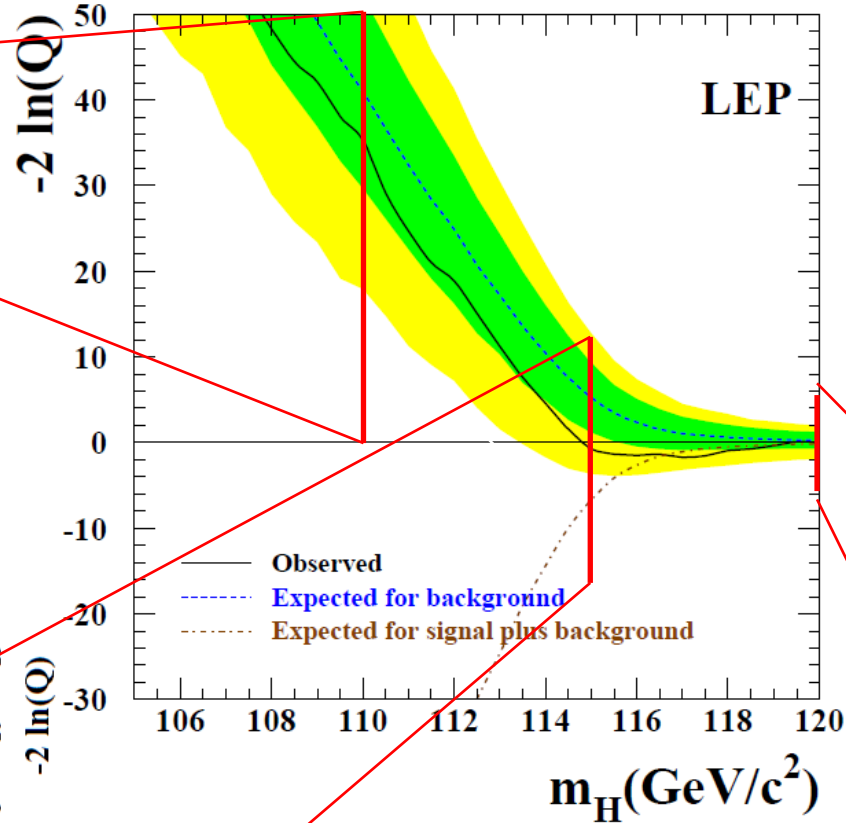
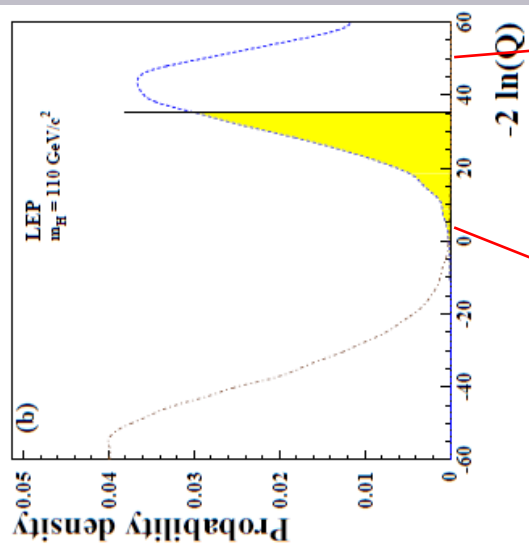
example:  $m_H=115\text{GeV}/c^2$

more signal like

more background like



# Example: LEP SM Higgs Limit

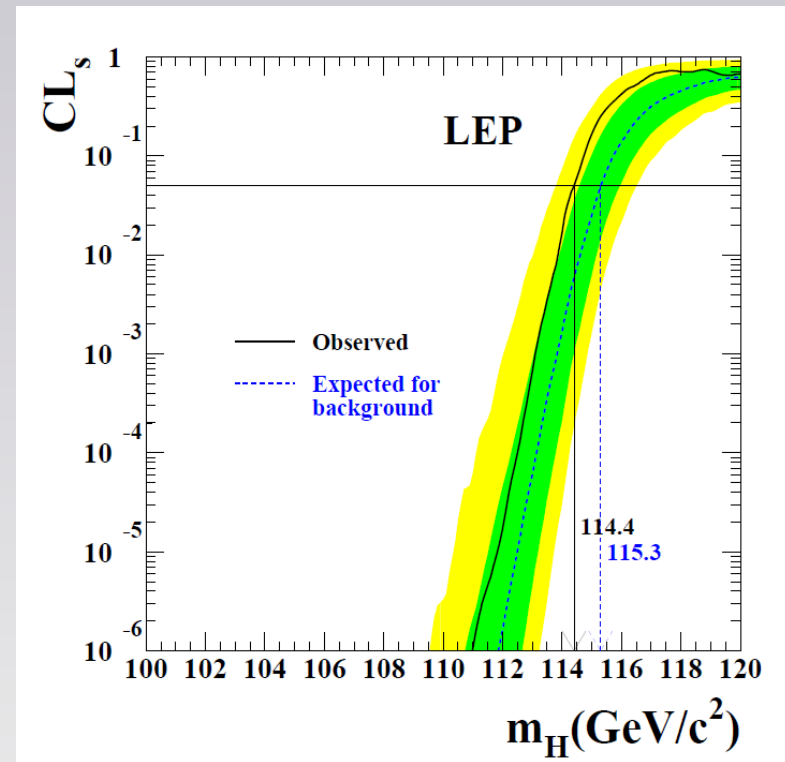
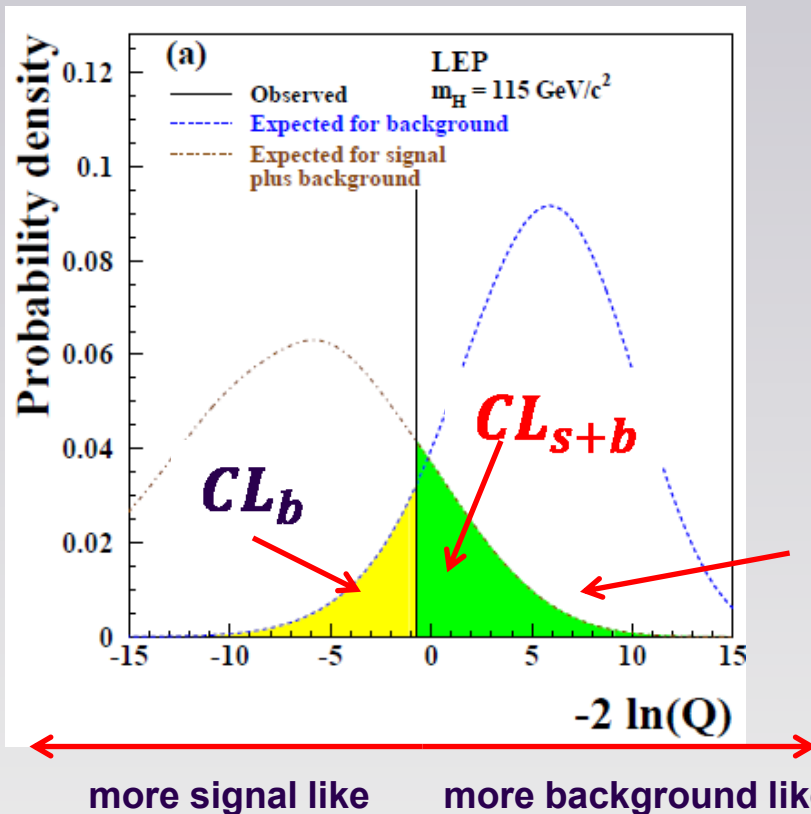




# Example LEP Higgs Search

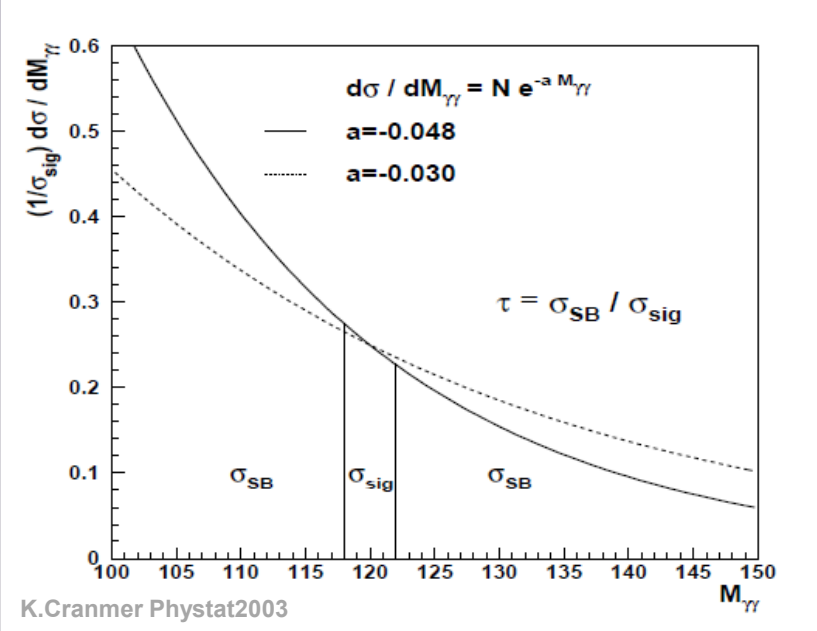
- In order to “avoid” the possible “problem” of Being Lucky when setting the limit
  - rather than “quoting” in addition the expected sensitivity
  - weight your  $CL_{s+b}$  by it:

$$CL_s = \frac{CL_{s+b}}{CL_b} = \frac{P(LLR \geq LLR_{obs} | H_1)}{P(LLR \leq LLR_{obs} | H_0)}$$



- standard popular way: (Cousin/Highland)
  - integrate over all systematic errors and their “Probability distribution)
  - → marginalisation of the “joint probability density of measurement parameters and systematic error)
- **! Bayesian ! (probability of the systematic parameter)**
- “hybrid” frequentist intervals and Bayesian systematic
- has been shown to have possible large “undercoverage” for very small p-values /large significances (i.e. underestimate the chance of “false discovery” !!)
- LEP-Higgs: generated MC to get the PDFs with “varying” param. with systematic uncertainty
  - essentially the same as “integrating over” → need probability density for “how these parameters vary”

- Why don't we:
  - include any systematic uncertainty as "free parameter" in the fit



- eg. measure background contribution under signal peak in sidebands
- measurement + extrapolation into side bands have uncertainty
- but you can parametrise your expected background such that:
  - if sideband measurement gives this data → then  $b = \dots$

**Note: no need to specify prior probability**

$$\underbrace{P(n_{\text{on}}, n_{\text{off}} | s, b)}_{\text{joint model}} = \underbrace{\text{Pois}(n_{\text{on}} | s + b)}_{\text{main measurement}} \underbrace{\text{Pois}(n_{\text{off}} | \tau b)}_{\text{sideband}}$$

- Build your **LIKELIHOOD FUNCTION** such that it includes:
  - your parameters of interest
  - those describing the influence of the sys. uncertainty
 → **nuisance parameters**

- Build your Likelihood function such that it includes:
    - your parameters of interest
    - those describing the influence of the sys. uncertainty
- nuisance parameters

$$\underbrace{P(n_{\text{on}}, n_{\text{off}} | s, b)}_{\text{joint model}} = \underbrace{\text{Pois}(n_{\text{on}} | s + b)}_{\text{main measurement}} \underbrace{\text{Pois}(n_{\text{off}} | \tau b)}_{\text{sideband}}$$

$$\tilde{\lambda}(\mu) = \frac{L(\mu, \hat{\hat{\theta}})}{L(\hat{\mu}, \hat{\theta})}, \quad 0 \leq \hat{\mu} \leq \mu$$

$$\tilde{\lambda}(\mu) = \frac{L(\mu, \hat{\theta})}{L(0, \hat{\theta})}, \quad \hat{\mu} < 0$$

$$= \frac{L(\mu, \hat{\theta})}{L(\hat{\mu}, \hat{\theta})}, \quad 0 \leq \hat{\mu} \leq \mu$$

“ratio of likelihoods”, why ?

# Profile Likelihood

$$\tilde{\lambda}(\mu) = \begin{cases} \frac{L(\mu, \hat{\hat{\theta}})}{L(\hat{\mu}, \hat{\hat{\theta}})}, & 0 \leq \hat{\mu} \leq \mu \\ \frac{L(\mu, \hat{\hat{\theta}})}{L(0, \hat{\hat{\theta}})}, & \hat{\mu} < 0 \end{cases} = \frac{L(\mu, \hat{\hat{\theta}})}{L(\hat{\mu}, \hat{\hat{\theta}})}, \quad 0 \leq \hat{\mu} \leq \mu$$

“ratio of likelihoods”, why ?

Why not simply using  $L(\mu, \theta)$  as test statistics ?

- The number of degrees of freedom of the fit would be  $N_{\theta} + 1_{\mu}$
- However, we are **not** interested in the values of  $\theta$  ( $\rightarrow$  they are *nuisance* !)
- Additional degrees of freedom dilute interesting information on  $\mu$
- The “profile likelihood” (= ratio of maximum likelihoods) concentrates the information on what we are interested in
- It is just as we usually do for chi-squared:  $\Delta\chi^2(m) = \chi^2(m, \theta_{\text{best}'}) - \chi^2(m_{\text{best}}, \theta_{\text{best}})$
- $N_{\text{d.o.f.}}$  of  $\Delta\chi^2(m)$  is 1, and value of  $\chi^2(m_{\text{best}}, \theta_{\text{best}})$  measures “Goodness-of-fit”

- **Maximum Likelihood fit** to estimate parameters
  
- **what to do if estimator is non-gaussian:**
  - **Neyman – confidence intervals**
  - **what “bothers” people with them**
  
- **Feldmans/Cousins confidence belts/intervals**
  - **unifies “limit” or “measurement” confidence belts**
  
- **CLs ... the HEP limit;**
  - **CLs ... ratio of “p-values” ... statisticians don’t like that**
  - **new idea: Power Constrained limits**
    - rather than specifying “sensitivity” and “Neyman conf. interval”
    - decide beforehand that you’ll “accept” limits only if the experiment has sufficient “power” i.e. “sensitivity” !
  
- **.. a bit about Profile Likelihood, systematic error.**